## **Supporting Information**

## Layered Tl<sub>2</sub>O: A Model Thermoelectric Material

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Figure S1.



Fig.S1. Band structures of bulk Tl<sub>2</sub>O at PBE level. The dash line denoted Fermi level.

Table S1. Effective masses along transport directions in bulk Tl2O calculated by using PBE. The effective mass is in the unit of free electron  $(m_e)$ 

	(m*) <sub>x</sub> (Γ-X)	(m*) <sub>y</sub> (Γ-Υ)	
hole	7.79	5.78	
electron	0.11	0.31	

Figure S2.



Fig.S2. Seebeck coefficient *S* as a function of carriers concentration at 300 K and 700 K along *x* and *y* directions for (a) SL, (b) BL and (c) TL Tl<sub>2</sub>O with *p*-type and *n*-type.

Figure S3.



Fig.S3. Electrical conductivities with respect to scattering time  $\sigma/\tau$  at room temperature as a function of carriers concentration along *x* and *y* directions for SL, BL, TL and bulk Tl<sub>2</sub>O with (a) *p*-type and (b) *n*-type.

Figure S4.



Fig.S4. Seebeck coefficient *S*, electronic conductivity with respect to scattering time  $\tau$  ( $\sigma/\tau$ ) and reduced power factor (S<sup>2</sup> $\sigma/\tau$ ) at room temperature as a function of carriers concentration along *x* and *y* directions for SL and bulk Tl<sub>2</sub>O with (a, c, e) p-type, (b, d, f) n-type, respectively.

Figure S5.



Fig.S5. Electrical conductivities as a function of carriers concentration along x and y directions at 300 K and 700 K for (a) single-layer, (b) bilayer and (c) trilayer Tl<sub>2</sub>O with *p*-type and *n*-type.

Figure S6.



Fig.S6. Power factor  $S^2 \sigma$  of (a)single-layer, (b) bilayer and (c) trilayer as a function of carriers concentration at 300 K and 700 K along *x* and *y* directions.

Figure S7.



Fig.S7. Calculated  $\kappa_l$  of single-layer Tl<sub>2</sub>O with relaxation time approximation (RTA) (dash line) and from the iterative solution (solid line) of BTE.

Figure S8.



Fig.S8. Charge density difference of SL  $Tl_2O$ . Orange represents charge accumulation and green represents charge depletion. Red atom denotes O and grey atom denotes Tl.

Figure S9.



Fig.S9. Calculated phonon lifetime at 300K of SL Tl<sub>2</sub>O.